

Search Notes

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Examiner

Chuck Huynh

Applicant(s)/Patent under
Reexamination

HICKS ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	10/24/2007	K
455	466	10/24/2007	AS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	10/24/2007	CH
Combined Text Search	10/24/2007	CH